

N-Channel Power MOSFET

40V, 96A, 5.1mΩ

FEATURES

- Low R_{DS(ON)} to minimize conductive losses
- Logic level
- Low gate charge for fast power switching
- 100% UIS and R_g tested
- Compliant to RoHS directive 2011/65/EU and in accordance to WEEE 2002/96/EC
- Halogen-free according to IEC 61249-2-21

KEY PERFORMANCE PARAMETERS				
PARAMETER		VALUE	UNIT	
V_{DS}		40	V	
R _{DS(on)} (max)	V _{GS} = 10V	5.1	•	
	$V_{GS} = 4.5V$	7	mΩ	
Q_g		22.6	nC	

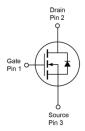
APPLICATIONS

- BLDC Motor Control
- Battery Power Management
- DC-DC converter
- Secondary Synchronous Rectification









Note: MSL 3 (Moisture Sensitivity Level) per J-STD-020

ABSOLUTE MAXIMUM RATINGS (T _A = 25°C unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	40	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current (Note 1)	$T_C = 25^{\circ}C$	l _D	96	А	
	$T_{C} = 25^{\circ}C$ $T_{A} = 25^{\circ}C$		16		
Pulsed Drain Current		I _{DM}	384	Α	
Single Pulse Avalanche Current (Note 2)		I _{AS}	25	А	
Single Pulse Avalanche Energy (Note 2)		E _{AS}	94	mJ	
Total Power Dissipation	$T_C = 25^{\circ}C$	P _D	89	\\\	
	$T_{\rm C} = 125^{\circ}{\rm C}$		18	W	
Total Power Dissipation	$T_A = 25$ °C	0	2.6	W	
	T _A = 125°C	$ P_{D}$	0.5		
Operating Junction and Storage Temp	perature Range	T _J , T _{STG}	- 55 to +150	°C	

THERMAL PERFORMANCE				
PARAMETER	SYMBOL	LIMIT	UNIT	
Junction to Case Thermal Resistance	R _{eJC}	1.4	°C/W	
Junction to Ambient Thermal Resistance	R _{OJA}	49	°C/W	

Thermal Performance Note: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistances. The case-thermal reference is defined at the solder mounting surface of the drain pins. $R_{\theta JA}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

1



PARAMETER	CONDITIONS	SYMBOL	MIN	TYP	MAX	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	BV _{DSS}	40			V
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	$V_{GS(TH)}$	1.2	1.7	2.5	V
Gate-Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	I _{GSS}			±100	nA
Drain-Source Leakage Current	$V_{GS} = 0V, V_{DS} = 40V$				1	μΑ
	$V_{GS} = 0V, V_{DS} = 40V$ $T_{J} = 125^{\circ}C$	I _{DSS}			100	
Drain-Source On-State Resistance	$V_{GS} = 10V, I_D = 16A$	_		4.3	5.1	mΩ
(Note 3)	$V_{GS} = 4.5V, I_D = 14A$	$R_{DS(on)}$		6	7	
Forward Transconductance (Note 3)	$V_{DS} = 5V, I_{D} = 16A$	g _{fs}		38		S
Dynamic (Note 4)						
Total Gate Charge	$V_{GS} = 10V, V_{DS} = 20V,$ $I_{D} = 16A$	Q_g		44.5		
Total Gate Charge		Q_g		22.6		nC
Gate-Source Charge	$V_{GS} = 4.5V, V_{DS} = 20V,$	Q _{gs}		6.7		1
Gate-Drain Charge	I _D = 14A	Q_{gd}		11		
Input Capacitance		C _{iss}		2456		
Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V$ f = 1.0MHz	C _{oss}		250		pF
Reverse Transfer Capacitance		C _{rss}		139		
Gate Resistance	f = 1.0MHz	R_g	0.3	1.05	2.1	Ω
Switching (Note 4)						
Turn-On Delay Time		t _{d(on)}		6		
Turn-On Rise Time	$V_{GS} = 10V, V_{DS} = 20V,$ $I_{D} = 16A, R_{G} = 2\Omega,$	t _r		16		
Turn-Off Delay Time		t _{d(off)}		23		ns
Turn-Off Fall Time		t _f		11		
Source-Drain Diode						
Forward Voltage (Note 3)	$V_{GS} = 0V, I_{S} = 16A$	V_{SD}			1	V
Reverse Recovery Time	I _S = 16A ,	t _{rr}		19		ns
Reverse Recovery Charge	dl/dt = 100A/µs	Q _{rr}		11		nC

Notes:

- 1. Silicon limited current only.
- 2. L = 0.3mH, $V_{GS} = 10$ V, $V_{DD} = 25$ V, $R_G = 25\Omega$, $I_{AS} = 25$ A, Starting $T_J = 25$ °C
- 3. Pulse test: Pulse Width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching time is essentially independent of operating temperature.

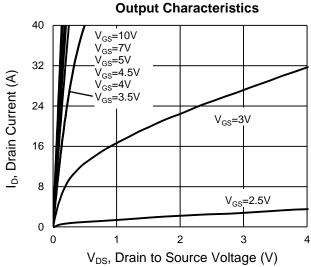
ORDERING INFORMATION

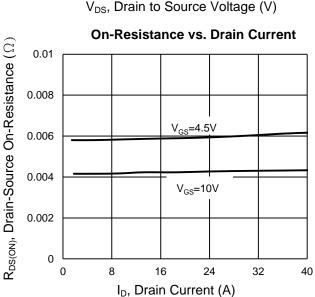
PART NO.	PACKAGE	PACKING
TSM051N04LCP ROG	TO-252 (DPAK)	2,500pcs / 13" Reel

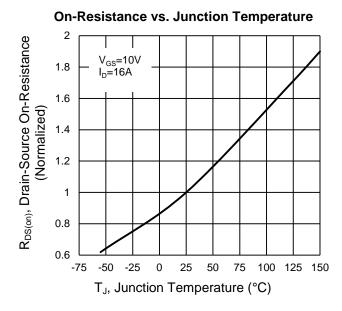


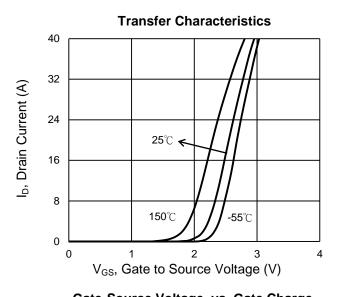
CHARACTERISTICS CURVES

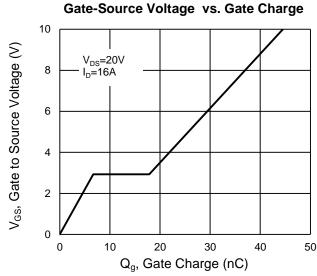
 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

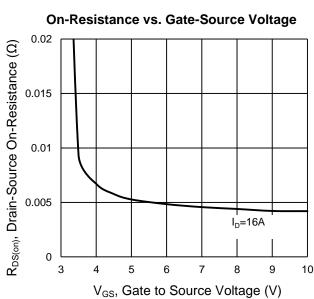










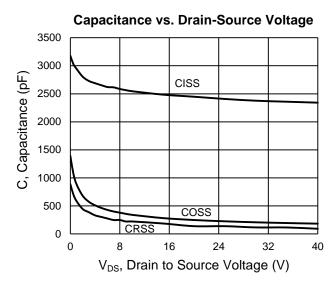


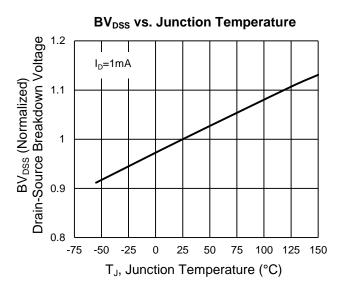
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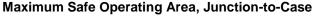


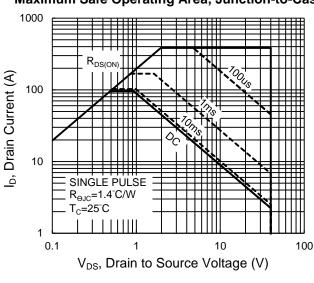
CHARACTERISTICS CURVES

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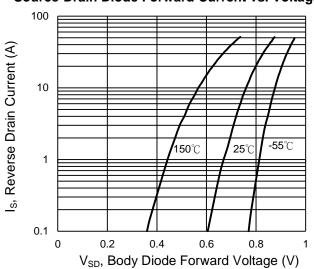




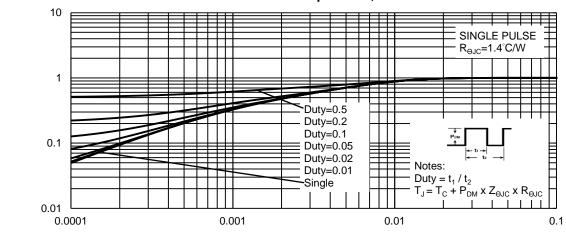
Normalized Effective Transient

Thermal Impedance, Zeuc

Source-Drain Diode Forward Current vs. Voltage



Normalized Thermal Transient Impedance, Junction-to-Case



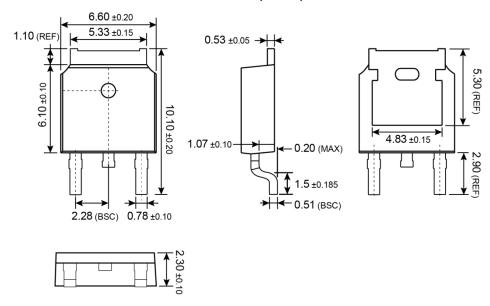
t, Square Wave Pulse Duration (sec)



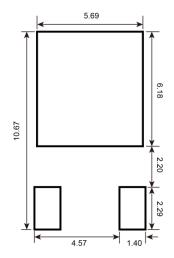
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PACKAGE OUTLINE DIMENSIONS (Unit: Millimeters)

TO-252 (DPAK)



SUGGESTED PAD LAYOUT (Unit: Millimeters)



MARKING DIAGRAM



Y = Year Code

M = Month Code

O =Jan P =Feb Q =Mar R =Apr

S =May T =Jun U =Jul V =Aug W =Sep X =Oct Y =Nov Z =Dec

5

 \mathbf{L} = Lot Code (1~9, A~Z)



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